International **100** Rectifier

POWER MOSFET THRU-HOLE (TO-257AA)

Product Summary

Part Number	RDS(on)	ID	Eyelets
IRFY240	0.18 Ω	16A	Glass
IRFY240M	0.18 Ω	16A	Glass

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

TO-257AA

IRFY240, IRFY240M

HEXFET[®] MOSFET TECHNOLOGY

200V, N-CHANNEL

Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Glass Eyelets
- For Space Level Applications Refer to Ceramic Version Part Numbers IRFY240C, IRFY240CM

	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	16	
ID @ VGS = 10V, TC = 100°C Continuous Drain Current		10.2	A
IDM	Pulsed Drain Current ①	64	
P _D @ T _C = 25°C	Max. Power Dissipation	100	W
	Linear Derating Factor	0.8	W/°C
VGS Gate-to-Source Voltage		±20	V
EAS Single Pulse Avalanche Energy 2		580	mJ
IAR Avalanche Current ①		16	A
EAR	Repetitive Avalanche Energy ①	10	mJ
dv/dt	Peak Diode Recovery dv/dt 3	5.0	V/ns
Тј	Operating Junction	-55 to 150	
TSTG Storage Temperature Range			°C
	Lead Temperature	300(0.063in./1.6mm from case for 10 sec)	
	Weight	3.3 (Typical)	g

Absolute Maximum Ratings

For footnotes refer to the last page

	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	200	—	—	V	$V_{GS} = 0V, I_{D} = 1.0mA$
$\Delta BV_{DSS}/\Delta T_{J}$	Temperature Coefficient of Breakdown Voltage	_	0.29	_	V/°C	Reference to 25°C, ID = 1.0mA
RDS(on)	Static Drain-to-Source On-State Resistance	_	_	0.18	Ω	VGS = 10V, ID = 10.2A $_{\textcircled{4}}$
VGS(th)	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
9fs	Forward Transconductance	6.1		—	S(7)	V _{DS} > 15V, I _{DS} = 10.2A ④
IDSS	Zero Gate Voltage Drain Current	—		25	μA	VDS= 160V ,VGS=0V
		—	—	250	μΑ	V _{DS} = 160V,
						$V_{GS} = 0V, T_{J} = 125^{\circ}C$
IGSS	Gate-to-Source Leakage Forward	_	—	100	nA	VGS = 20V
IGSS	Gate-to-Source Leakage Reverse -		_	-100	nA	VGS = -20V
Qg	Total Gate Charge		—	60		VGS =10V, ID = 16A
Qgs	Gate-to-Source Charge	_	—	10.6	nC	$V_{DS} = 50V$
Q _{gd}	Gate-to-Drain ('Miller') Charge	_	_	37.6		
^t d(on)	Turn-On Delay Time	_	—	20		V _{DD} = 100V, I _D = 16A,
tr	Rise Time		_	152		R _G = 9.1Ω
^t d(off)	Turn-Off Delay Time	_	—	58	ns	
tf	FallTime	_	—	67		
LS+LD	Total Inductance		6.8	—	nH	Measured from drain lead (6mm/0.25in. from
						package) to source lead (6mm/0.25in. from package)
C _{iss}	Input Capacitance	—	1300			$V_{GS} = 0V, V_{DS} = 25V$
C _{oss}	Output Capacitance	_	400	—	pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance	_	130	—		

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
IS	Continuous Source Current	(Body Diode)		_	16	٨	
ISM	Pulse Source Current (Body Diode) ① -		—	—	64	A	
VSD	Diode Forward Voltage		—	—	1.5	V	Tj = 25°C, IS = 16A, VGS = 0V ④
trr	Reverse Recovery Time		—	—	500	nS	Tj = 25°C, IF = 16A, di/dt ≤ 100A/μs
QRR	Reverse Recovery Charge		—	—	5.3	μC	V _{DD} ≤ 50V ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L_S + $L_D.$					

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
R _{th} JC	Junction-to-Case	-	—	1.25		
RthCS	Case-to-sink	—	0.21	—	°C/W	
R _{th} JA	Junction-to-Ambient	—	—	80		Typical socket mount

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

International

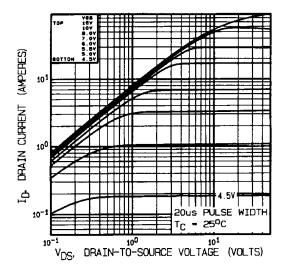


Fig 1. Typical Output Characteristics

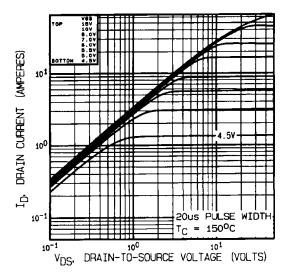
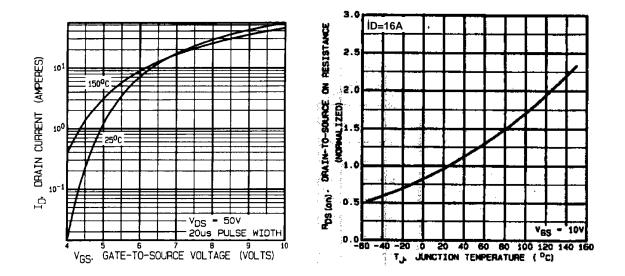
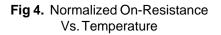
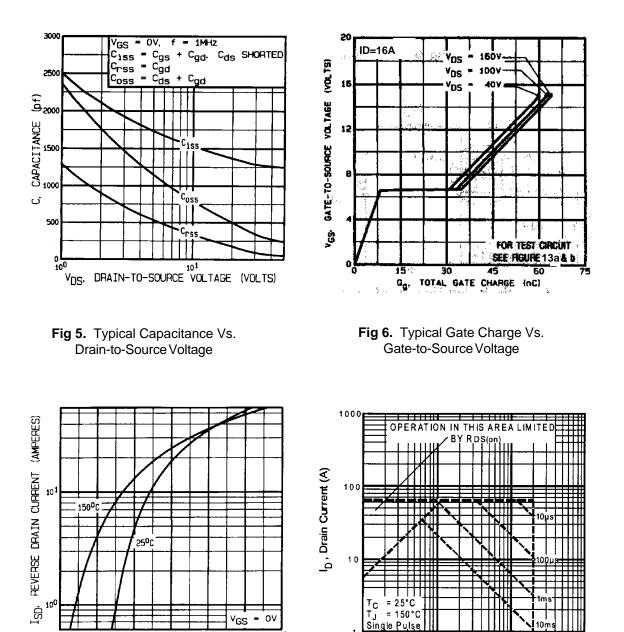


Fig 2. Typical Output Characteristics









4 0.6 0.8 1.0 1.2 1.4 V_{SD}, SOURCE-TO-DRAIN VOLTAGE (VOLTS) 0.4



Fig 8. Maximum Safe Operating Area

V_{DS}, Drain-to-Source Voltage (V)

10

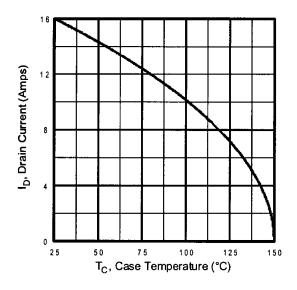
1000

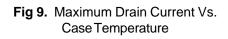
100

1.6

1

International





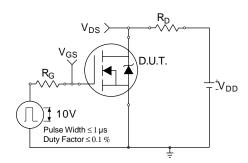


Fig 10a. Switching Time Test Circuit

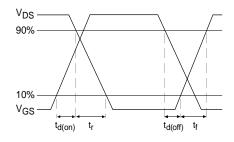


Fig 10b. Switching Time Waveforms

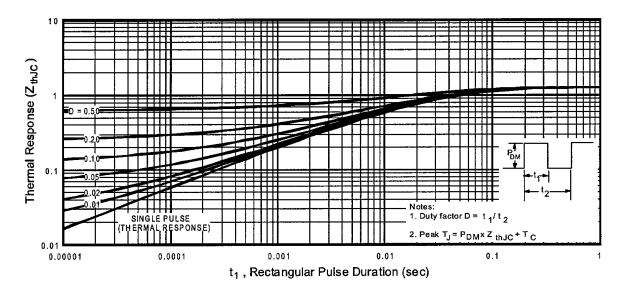


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

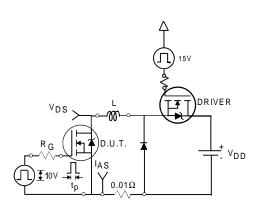


Fig 12a. Unclamped Inductive Test Circuit

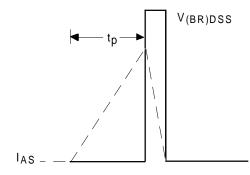


Fig 12b. Unclamped Inductive Waveforms

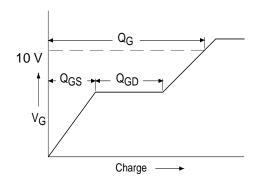


Fig 13a. Basic Gate Charge Waveform

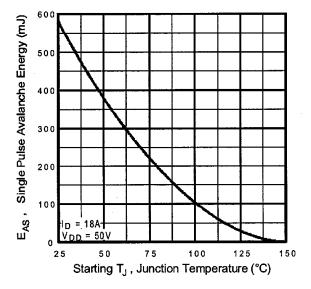


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

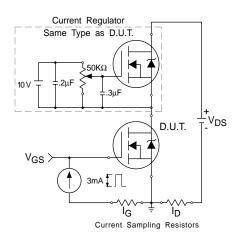


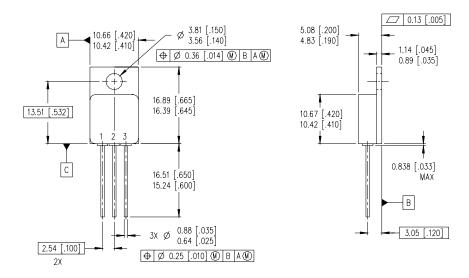
Fig 13b. Gate Charge Test Circuit

International

Footnotes:

- Repetitive Rating; Pulse width limited by maximum junction temperature.
- \odot VDD = 50V, starting TJ = 25°C, L= 4.5mH Peak IL = 16A, VGS = 10V
- ④ Pulse width \leq 300 µs; Duty Cycle \leq 2%

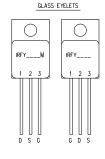
Case Outline and Dimensions — TO-257AA



NOTES:

- 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4. OUTLINE CONFORMS TO JEDEC OUTLINE TO-257AA.

LEGEND							
	D	_	DRAIN				
	S	_	SOURCE				
	G	-	GATE				



International **ICR** Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 TAC Fax: (310) 252-7903 Visit us at www.irf.com for sales contact information.

Data and specifications subject to change without notice. 04/01



单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon Technologies(英飞凌)